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#### Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	80
Number of Logic Elements/Cells	640
Total RAM Bits	65536
Number of I/O	100
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	121-VFBGA, CSPBGA
Supplier Device Package	121-CSFBGA (6x6)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lcmxo3lf-640e-5mg121c

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



and oscillators dynamically. These features help manage static and dynamic power consumption resulting in low static power for all members of the family.

The MachXO3L/LF devices are available in two versions C and E with two speed grades: -5 and -6, with -6 being the fastest. C devices have an internal linear voltage regulator which supports external VCC supply voltages of 3.3 V or 2.5 V. E devices only accept 1.2 V as the external VCC supply voltage. With the exception of power supply voltage both C and E are functionally compatible with each other.

The MachXO3L/LF PLDs are available in a broad range of advanced halogen-free packages ranging from the space saving 2.5 x 2.5 mm WLCSP to the 19 x 19 mm caBGA. MachXO3L/LF devices support density migration within the same package. Table 1-1 shows the LUT densities, package and I/O options, along with other key parameters.

The MachXO3L/LF devices offer enhanced I/O features such as drive strength control, slew rate control, PCI compatibility, bus-keeper latches, pull-up resistors, pull-down resistors, open drain outputs and hot socketing. Pull-up, pull-down and bus-keeper features are controllable on a "per-pin" basis.

A user-programmable internal oscillator is included in MachXO3L/LF devices. The clock output from this oscillator may be divided by the timer/counter for use as clock input in functions such as LED control, key-board scanner and similar state machines.

The MachXO3L/LF devices also provide flexible, reliable and secure configuration from on-chip NVCM/Flash. These devices can also configure themselves from external SPI Flash or be configured by an external master through the JTAG test access port or through the I<sup>2</sup>C port. Additionally, MachXO3L/LF devices support dual-boot capability (using external Flash memory) and remote field upgrade (TransFR) capability.

Lattice provides a variety of design tools that allow complex designs to be efficiently implemented using the MachXO3L/LF family of devices. Popular logic synthesis tools provide synthesis library support for MachXO3L/LF. Lattice design tools use the synthesis tool output along with the user-specified preferences and constraints to place and route the design in the MachXO3L/LF device. These tools extract the timing from the routing and back-annotate it into the design for timing verification.

Lattice provides many pre-engineered IP (Intellectual Property) LatticeCORE<sup>™</sup> modules, including a number of reference designs licensed free of charge, optimized for the MachXO3L/LF PLD family. By using these configurable soft core IP cores as standardized blocks, users are free to concentrate on the unique aspects of their design, increasing their productivity.







 MachXO3L/LF-1300, MachXO3L/LF-2100, MachXO3L/LF-6900 and MachXO3L/LF-9400 are similar to MachXO3L/LF-4300. MachXO3L/LF-1300 has a lower LUT count, one PLL, and seven EBR blocks. MachXO3L/LF-2100 has a lower LUT count, one PLL, and eight EBR blocks. MachXO3L/LF-6900 has a higher LUT count, two PLLs, and 26 EBR blocks. MachXO3L/LF-9400 has a higher LUT count, two PLLs, and 48 EBR blocks.

• MachXO3L devices have NVCM, MachXO3LF devices have Flash.

The logic blocks, Programmable Functional Unit (PFU) and sysMEM EBR blocks, are arranged in a two-dimensional grid with rows and columns. Each row has either the logic blocks or the EBR blocks. The PIO cells are located at the periphery of the device, arranged in banks. The PFU contains the building blocks for logic, arithmetic, RAM, ROM, and register functions. The PIOs utilize a flexible I/O buffer referred to as a sysIO buffer that supports operation with a variety of interface standards. The blocks are connected with many vertical and horizontal routing channel resources. The place and route software tool automatically allocates these routing resources.

In the MachXO3L/LF family, the number of sysIO banks varies by device. There are different types of I/O buffers on the different banks. Refer to the details in later sections of this document. The sysMEM EBRs are large, dedicated fast memory blocks. These blocks can be configured as RAM, ROM or FIFO. FIFO support includes dedicated FIFO pointer and flag "hard" control logic to minimize LUT usage.

The MachXO3L/LF registers in PFU and sysI/O can be configured to be SET or RESET. After power up and device is configured, the device enters into user mode with these registers SET/RESET according to the configuration setting, allowing device entering to a known state for predictable system function.

The MachXO3L/LF architecture also provides up to two sysCLOCK Phase Locked Loop (PLL) blocks. These blocks are located at the ends of the on-chip NVCM/Flash block. The PLLs have multiply, divide, and phase shifting capabilities that are used to manage the frequency and phase relationships of the clocks.

MachXO3L/LF devices provide commonly used hardened functions such as SPI controller, I<sup>2</sup>C controller and timer/ counter.

MachXO3LF devices also provide User Flash Memory (UFM). These hardened functions and the UFM interface to the core logic and routing through a WISHBONE interface. The UFM can also be accessed through the SPI, I<sup>2</sup>C and JTAG ports.

Every device in the family has a JTAG port that supports programming and configuration of the device as well as access to the user logic. The MachXO3L/LF devices are available for operation from 3.3 V, 2.5 V and 1.2 V power sup-plies, providing easy integration into the overall system.



### **ROM Mode**

ROM mode uses the LUT logic; hence, slices 0-3 can be used in ROM mode. Preloading is accomplished through the programming interface during PFU configuration.

For more information on the RAM and ROM modes, please refer to TN1290, Memory Usage Guide for MachXO3 Devices.

## Routing

There are many resources provided in the MachXO3L/LF devices to route signals individually or as buses with related control signals. The routing resources consist of switching circuitry, buffers and metal interconnect (routing) segments.

The inter-PFU connections are made with three different types of routing resources: x1 (spans two PFUs), x2 (spans three PFUs) and x6 (spans seven PFUs). The x1, x2, and x6 connections provide fast and efficient connections in the horizontal and vertical directions.

The design tools take the output of the synthesis tool and places and routes the design. Generally, the place and route tool is completely automatic, although an interactive routing editor is available to optimize the design.

## **Clock/Control Distribution Network**

Each MachXO3L/LF device has eight clock inputs (PCLK [T, C] [Banknum]\_[2..0]) – three pins on the left side, two pins each on the bottom and top sides and one pin on the right side. These clock inputs drive the clock nets. These eight inputs can be differential or single-ended and may be used as general purpose I/O if they are not used to drive the clock nets. When using a single ended clock input, only the PCLKT input can drive the clock tree directly.

The MachXO3L/LF architecture has three types of clocking resources: edge clocks, primary clocks and secondary high fanout nets. MachXO3L/LF devices have two edge clocks each on the top and bottom edges. Edge clocks are used to clock I/O registers and have low injection time and skew. Edge clock inputs are from PLL outputs, primary clock pads, edge clock bridge outputs and CIB sources.

The eight primary clock lines in the primary clock network drive throughout the entire device and can provide clocks for all resources within the device including PFUs, EBRs and PICs. In addition to the primary clock signals, MachXO3L/LF devices also have eight secondary high fanout signals which can be used for global control signals, such as clock enables, synchronous or asynchronous clears, presets, output enables, etc. Internal logic can drive the global clock network for internally-generated global clocks and control signals.

The maximum frequency for the primary clock network is shown in the MachXO3L/LF External Switching Characteristics table.

Primary clock signals for the MachXO3L/LF-1300 and larger devices are generated from eight 27:1 muxes The available clock sources include eight I/O sources, 11 routing inputs, eight clock divider inputs and up to eight sys-CLOCK PLL outputs.



Port Name	Description	Active State
CLK	Clock	Rising Clock Edge
CE	Clock Enable	Active High
OCE <sup>1</sup>	Output Clock Enable	Active High
RST	Reset	Active High
BE <sup>1</sup>	Byte Enable	Active High
WE	Write Enable	Active High
AD	Address Bus	—
DI	Data In	_
DO	Data Out	_
CS	Chip Select	Active High
AFF	FIFO RAM Almost Full Flag	_
FF	FIFO RAM Full Flag	_
AEF	FIFO RAM Almost Empty Flag	_
EF	FIFO RAM Empty Flag	_
RPRST	FIFO RAM Read Pointer Reset	_

#### Table 2-6. EBR Signal Descriptions

1. Optional signals.

2. For dual port EBR primitives a trailing 'A' or 'B' in the signal name specifies the EBR port A or port B respectively.

3. For FIFO RAM mode primitive, a trailing 'R' or 'W' in the signal name specifies the FIFO read port or write port respectively.

4. For FIFO RAM mode primitive FULLI has the same function as CSW(2) and EMPTYI has the same function as CSR(2).

In FIFO mode, CLKW is the write port clock, CSW is the write port chip select, CLKR is the read port clock, CSR is the read port clock, CSR is the read port clock.

The EBR memory supports three forms of write behavior for single or dual port operation:

- 1. **Normal** Data on the output appears only during the read cycle. During a write cycle, the data (at the current address) does not appear on the output. This mode is supported for all data widths.
- 2. Write Through A copy of the input data appears at the output of the same port. This mode is supported for all data widths.
- 3. Read-Before-Write When new data is being written, the old contents of the address appears at the output.

#### **FIFO Configuration**

The FIFO has a write port with data-in, CEW, WE and CLKW signals. There is a separate read port with data-out, RCE, RE and CLKR signals. The FIFO internally generates Almost Full, Full, Almost Empty and Empty Flags. The Full and Almost Full flags are registered with CLKW. The Empty and Almost Empty flags are registered with CLKR. Table 2-7 shows the range of programming values for these flags.

#### Table 2-7. Programmable FIFO Flag Ranges

Flag Name	Programming Range
Full (FF)	1 to max (up to 2 <sup>N</sup> -1)
Almost Full (AF)	1 to Full-1
Almost Empty (AE)	1 to Full-1
Empty (EF)	0

N = Address bit width.

The FIFO state machine supports two types of reset signals: RST and RPRST. The RST signal is a global reset that clears the contents of the FIFO by resetting the read/write pointer and puts the FIFO flags in their initial reset



## **Output Register Block**

The output register block registers signals from the core of the device before they are passed to the sysIO buffers.

#### Left, Top, Bottom Edges

In SDR mode, D0 feeds one of the flip-flops that then feeds the output. The flip-flop can be configured as a D-type register or latch.

In DDR generic mode, D0 and D1 inputs are fed into registers on the positive edge of the clock. At the next falling edge the registered D1 input is registered into the register Q1. A multiplexer running off the same clock is used to switch the mux between the outputs of registers Q0 and Q1 that will then feed the output.

Figure 2-12 shows the output register block on the left, top and bottom edges.

Figure 2-12. MachXO3L/LF Output Register Block Diagram (PIO on the Left, Top and Bottom Edges)



### Tri-state Register Block

The tri-state register block registers tri-state control signals from the core of the device before they are passed to the sysIO buffers. The block contains a register for SDR operation. In SDR, TD input feeds one of the flip-flops that then feeds the output.



### Figure 2-13. Input Gearbox



More information on the input gearbox is available in TN1281, Implementing High-Speed Interfaces with MachXO3 Devices.



## sysIO Buffer

Each I/O is associated with a flexible buffer referred to as a sysIO buffer. These buffers are arranged around the periphery of the device in groups referred to as banks. The sysIO buffers allow users to implement a wide variety of standards that are found in today's systems including LVCMOS, TTL, PCI, LVDS, BLVDS, MLVDS and LVPECL.

Each bank is capable of supporting multiple I/O standards. In the MachXO3L/LF devices, single-ended output buffers, ratioed input buffers (LVTTL, LVCMOS and PCI), differential (LVDS) input buffers are powered using I/O supply voltage ( $V_{CCIO}$ ). Each sysIO bank has its own  $V_{CCIO}$ .

MachXO3L/LF devices contain three types of sysIO buffer pairs.

#### 1. Left and Right sysIO Buffer Pairs

The sysIO buffer pairs in the left and right banks of the device consist of two single-ended output drivers and two single-ended input buffers (for ratioed inputs such as LVCMOS and LVTTL). The I/O pairs on the left and right of the devices also have differential input buffers.

#### 2. Bottom sysIO Buffer Pairs

The sysIO buffer pairs in the bottom bank of the device consist of two single-ended output drivers and two single-ended input buffers (for ratioed inputs such as LVCMOS and LVTTL). The I/O pairs on the bottom also have differential input buffers. Only the I/Os on the bottom banks have programmable PCI clamps and differential input termination. The PCI clamp is enabled after  $V_{CC}$  and  $V_{CCIO}$  are at valid operating levels and the device has been configured.

#### 3. Top sysIO Buffer Pairs

The sysIO buffer pairs in the top bank of the device consist of two single-ended output drivers and two singleended input buffers (for ratioed inputs such as LVCMOS and LVTTL). The I/O pairs on the top also have differential I/O buffers. Half of the sysIO buffer pairs on the top edge have true differential outputs. The sysIO buffer pair comprising of the A and B PIOs in every PIC on the top edge have a differential output driver.

### Typical I/O Behavior During Power-up

The internal power-on-reset (POR) signal is deactivated when  $V_{CC}$  and  $V_{CCIO0}$  have reached  $V_{PORUP}$  level defined in the Power-On-Reset Voltage table in the DC and Switching Characteristics section of this data sheet. After the POR signal is deactivated, the FPGA core logic becomes active. It is the user's responsibility to ensure that all  $V_{CCIO}$  banks are active with valid input logic levels to properly control the output logic states of all the I/O banks that are critical to the application. The default configuration of the I/O pins in a blank device is tri-state with a weak pulldown to GND (some pins such as PROGRAMN and the JTAG pins have weak pull-up to  $V_{CCIO}$  as the default functionality). The I/O pins will maintain the blank configuration until  $V_{CC}$  and  $V_{CCIO}$  (for I/O banks containing configuration I/Os) have reached  $V_{PORUP}$  levels at which time the I/Os will take on the user-configured settings only after a proper download/configuration.

There are various ways a user can ensure that there are no spurious signals on critical outputs as the device powers up. These are discussed in more detail in TN1280, MachXO3 sysIO Usage Guide.

### **Supported Standards**

The MachXO3L/LF sysIO buffer supports both single-ended and differential standards. Single-ended standards can be further subdivided into LVCMOS, LVTTL, and PCI. The buffer supports the LVTTL, PCI, LVCMOS 1.2 V, 1.5 V, 1.8 V, 2.5 V, and 3.3 V standards. In the LVCMOS and LVTTL modes, the buffer has individually configurable options for drive strength, bus maintenance (weak pull-up, weak pull-down, bus-keeper latch or none) and open drain. BLVDS, MLVDS and LVPECL output emulation is supported on all devices. The MachXO3L/LF devices support on-chip LVDS output buffers on approximately 50% of the I/Os on the top bank. Differential receivers for LVDS, BLVDS, MLVDS and LVPECL are supported on all banks of MachXO3L/LF devices. PCI support is provided in the bottom bank of the MachXO3L/LF devices. Table 2-11 summarizes the I/O characteristics of the MachXO3L/LF PLDs.



### Hardened Timer/Counter

MachXO3L/LF devices provide a hard Timer/Counter IP core. This Timer/Counter is a general purpose, bi-directional, 16-bit timer/counter module with independent output compare units and PWM support. The Timer/Counter supports the following functions:

- Supports the following modes of operation:
  - Watchdog timer
  - Clear timer on compare match
  - Fast PWM
  - Phase and Frequency Correct PWM
- Programmable clock input source
- Programmable input clock prescaler
- One static interrupt output to routing
- One wake-up interrupt to on-chip standby mode controller.
- Three independent interrupt sources: overflow, output compare match, and input capture
- Auto reload
- Time-stamping support on the input capture unit
- Waveform generation on the output
- Glitch-free PWM waveform generation with variable PWM period
- Internal WISHBONE bus access to the control and status registers
- · Stand-alone mode with preloaded control registers and direct reset input

#### Figure 2-20. Timer/Counter Block Diagram



Table 2-16. Timer/Counter Signal Description

Port	I/O	Description
tc_clki	I	Timer/Counter input clock signal
tc_rstn	I	Register tc_rstn_ena is preloaded by configuration to always keep this pin enabled
tc_ic	I	Input capture trigger event, applicable for non-pwm modes with WISHBONE interface. If enabled, a rising edge of this signal will be detected and synchronized to capture tc_cnt value into tc_icr for time-stamping.
tc_int	0	Without WISHBONE – Can be used as overflow flag With WISHBONE – Controlled by three IRQ registers
tc_oc	0	Timer counter output signal



#### Security and One-Time Programmable Mode (OTP)

For applications where security is important, the lack of an external bitstream provides a solution that is inherently more secure than SRAM-based FPGAs. This is further enhanced by device locking. MachXO3L/LF devices contain security bits that, when set, prevent the readback of the SRAM configuration and NVCM/Flash spaces. The device can be in one of two modes:

- 1. Unlocked Readback of the SRAM configuration and NVCM/Flash spaces is allowed.
- 2. Permanently Locked The device is permanently locked.

Once set, the only way to clear the security bits is to erase the device. To further complement the security of the device, a One Time Programmable (OTP) mode is available. Once the device is set in this mode it is not possible to erase or re-program the NVCM/Flash and SRAM OTP portions of the device. For more details, refer to TN1279, MachXO3 Programming and Configuration Usage Guide.

#### Password

The MachXO3LF supports a password-based security access feature also known as Flash Protect Key. Optionally, the MachXO3L device can be ordered with a custom specification (c-spec) to support this feature. The Flash Protect Key feature provides a method of controlling access to the Configuration and Programming modes of the device. When enabled, the Configuration and Programming edit mode operations (including Write, Verify and Erase operations) are allowed only when coupled with a Flash Protect Key which matches that expected by the device. Without a valid Flash Protect Key, the user can perform only rudimentary non-configuration operations such as Read Device ID. For more details, refer to TN1313, Using Password Security with MachXO3 Devices.

#### **Dual Boot**

MachXO3L/LF devices can optionally boot from two patterns, a primary bitstream and a golden bitstream. If the primary bitstream is found to be corrupt while being downloaded into the SRAM, the device shall then automatically re-boot from the golden bitstream. Note that the primary bitstream must reside in the external SPI Flash. The golden image MUST reside in an on-chip NVCM/Flash. For more details, refer to TN1279, MachXO3 Programming and Configuration Usage Guide.

#### Soft Error Detection

The SED feature is a CRC check of the SRAM cells after the device is configured. This check ensures that the SRAM cells were configured successfully. This feature is enabled by a configuration bit option. The Soft Error Detection can also be initiated in user mode via an input to the fabric. The clock for the Soft Error Detection circuit is generated using a dedicated divider. The undivided clock from the on-chip oscillator is the input to this divider. For low power applications users can switch off the Soft Error Detection circuit. For more details, refer to TN1292, MachXO3 Soft Error Detection Usage Guide.

#### Soft Error Correction

The MachXO3LF device supports Soft Error Correction (SEC). Optionally, the MachXO3L device can be ordered with a custom specification (c-spec) to support this feature. When BACKGROUND\_RECONFIG is enabled using the Lattice Diamond Software in a design, asserting the PROGRAMN pin or issuing the REFRESH sysConfig command refreshes the SRAM array from configuration memory. Only the detected error bit is corrected. No other SRAM cells are changed, allowing the user design to function uninterrupted.

During the project design phase, if the overall system cannot guarantee containment of the error or its subsequent effects on downstream data or control paths, Lattice recommends using SED only. The MachXO3 can be then be soft-reset by asserting PROGRAMN or issuing the Refresh command over a sysConfig port in response to SED. Soft-reset additionally erases the SRAM array prior to the SRAM refresh, and asserts internal Reset circuitry to guarantee a known state. For more details, refer to TN1292, MachXO3 Soft Error Detection (SED)/Correction (SEC) Usage Guide.



# **DC Electrical Characteristics**

Parameter	Condition	Min.	Тур.	Max.	Units
	Clamp OFF and $V_{CCIO} < V_{IN} < V_{IH}$ (MAX)		_	+175	μA
	Clamp OFF and $V_{IN} = V_{CCIO}$	-10	_	10	μA
Input or I/O Leakage	Clamp OFF and V <sub>CCIO</sub> - 0.97 V < V <sub>IN</sub> < V <sub>CCIO</sub>	-175		—	μΑ
	Clamp OFF and 0 V < $V_{IN}$ < $V_{CCIO}$ - 0.97 V		_	10	μA
	Clamp OFF and V <sub>IN</sub> = GND		_	10	μA
	Clamp ON and 0 V < V <sub>IN</sub> < V <sub>CCIO</sub>		_	10	μA
I/O Active Pull-up Current	0 < V <sub>IN</sub> < 0.7 V <sub>CCIO</sub>	-30		-309	μA
I/O Active Pull-down Current	V <sub>IL</sub> (MAX) < V <sub>IN</sub> < V <sub>CCIO</sub>	30		305	μA
Bus Hold Low sustaining current	$V_{IN} = V_{IL} (MAX)$	30		—	μΑ
Bus Hold High sustaining current	V <sub>IN</sub> = 0.7V <sub>CCIO</sub>	-30	_	_	μΑ
Bus Hold Low Overdrive current	$0 \leq V_{IN} \leq V_{CCIO}$	_	_	305	μΑ
Bus Hold High Overdrive current	$0 \le V_{IN} \le V_{CCIO}$	_	_	-309	μA
Bus Hold Trip Points		V <sub>IL</sub> (MAX)	_	V <sub>IH</sub> (MIN)	V
I/O Capacitance <sup>2</sup>	$V_{CCIO} = 3.3 V, 2.5 V, 1.8 V, 1.5 V, 1.2 V, V_{CC} = Typ., V_{IO} = 0 to V_{IH} (MAX)$	3	5	9	pf
Dedicated Input Capacitance <sup>2</sup>	$V_{CCIO} = 3.3 V, 2.5 V, 1.8 V, 1.5 V, 1.2 V, V_{CC} = Typ., V_{IO} = 0 to V_{IH} (MAX)$	3	5.5	7	pf
	V <sub>CCIO</sub> = 3.3 V, Hysteresis = Large		450		mV
	V <sub>CCIO</sub> = 2.5 V, Hysteresis = Large		250		mV
	V <sub>CCIO</sub> = 1.8 V, Hysteresis = Large		125		mV
Hysteresis for Schmitt	V <sub>CCIO</sub> = 1.5 V, Hysteresis = Large		100		mV
Trigger Inputs⁵	V <sub>CCIO</sub> = 3.3 V, Hysteresis = Small		250		mV
	V <sub>CCIO</sub> = 2.5 V, Hysteresis = Small		150		mV
	V <sub>CCIO</sub> = 1.8 V, Hysteresis = Small		60		mV
	V <sub>CCIO</sub> = 1.5 V, Hysteresis = Small		40		mV
	Input or I/O Leakage         I/O Active Pull-up Current         I/O Active Pull-down         Current         Bus Hold Low sustaining         current         Bus Hold Low sustaining         current         Bus Hold Low Overdrive         current         Bus Hold Low Overdrive         current         Bus Hold High Overdrive         current         Bus Hold Trip Points         I/O Capacitance <sup>2</sup> Dedicated Input         Capacitance <sup>2</sup>	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$

1. Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tri-stated. It is not measured with the output driver active. Bus maintenance circuits are disabled.

2. T<sub>A</sub> 25 °C, f = 1.0 MHz.

3. Please refer to V<sub>IL</sub> and V<sub>IH</sub> in the sysIO Single-Ended DC Electrical Characteristics table of this document.

 When V<sub>IH</sub> is higher than V<sub>CCIO</sub>, a transient current typically of 30 ns in duration or less with a peak current of 6mA can occur on the high-tolow transition. For true LVDS output pins in MachXO3L/LF devices, V<sub>IH</sub> must be less than or equal to V<sub>CCIO</sub>.

5. With bus keeper circuit turned on. For more details, refer to TN1280, MachXO3 sysIO Usage Guide.



# sysIO Recommended Operating Conditions

		V <sub>CCIO</sub> (V)		V <sub>REF</sub> (V)				
Standard	Min.	Тур.	Max.	Min.	Тур.	Max.		
LVCMOS 3.3	3.135	3.3	3.465	—	—	—		
LVCMOS 2.5	2.375	2.5	2.625	—	—	—		
LVCMOS 1.8	1.71	1.8	1.89	—	—	—		
LVCMOS 1.5	1.425	1.5	1.575	—	—	—		
LVCMOS 1.2	1.14	1.2	1.26	—	—	—		
LVTTL	3.135	3.3	3.465	—	—	—		
LVDS25 <sup>1, 2</sup>	2.375	2.5	2.625	—	—	—		
LVDS33 <sup>1, 2</sup>	3.135	3.3	3.465	—	—	—		
LVPECL <sup>1</sup>	3.135	3.3	3.465	—	—	—		
BLVDS <sup>1</sup>	2.375	2.5	2.625	—	—	—		
MIPI <sup>3</sup>	2.375	2.5	2.625	—	—	—		
MIPI_LP <sup>3</sup>	1.14	1.2	1.26	—	—	_		
LVCMOS25R33	3.135	3.3	3.6	1.1	1.25	1.4		
LVCMOS18R33	3.135	3.3	3.6	0.75	0.9	1.05		
LVCMOS18R25	2.375	2.5	2.625	0.75	0.9	1.05		
LVCMOS15R33	3.135	3.3	3.6	0.6	0.75	0.9		
LVCMOS15R25	2.375	2.5	2.625	0.6	0.75	0.9		
LVCMOS12R334	3.135	3.3	3.6	0.45	0.6	0.75		
LVCMOS12R254	2.375	2.5	2.625	0.45	0.6	0.75		
LVCMOS10R334	3.135	3.3	3.6	0.35	0.5	0.65		
LVCMOS10R254	2.375	2.5	2.625	0.35	0.5	0.65		

1. Inputs on-chip. Outputs are implemented with the addition of external resistors.

2. For the dedicated LVDS buffers.

3. Requires the addition of external resistors.

4. Supported only for inputs and BIDIs for -6 speed grade devices.



# sysIO Single-Ended DC Electrical Characteristics<sup>1, 2</sup>

Input/Output	V	IL	V	IH	V <sub>OL</sub> Max.	V <sub>OH</sub> Min.	I <sub>OL</sub> Max.⁴	l <sub>OH</sub> Max.⁴
Standard	Min. (V) <sup>3</sup>	Max. (V)	Min. (V)	Max. (V)	(V)	(V)	(mA)	(mA)
							4	-4
					0.4	V <sub>CCIO</sub> - 0.4	8	-8
LVCMOS 3.3 LVTTL	-0.3	0.8	2.0	3.6	0.4	CCIO - 0.4	12	-12
							16	-16
					0.2	V <sub>CCIO</sub> - 0.2	0.1	-0.1
							4	-4
					0.4	V <sub>CCIO</sub> - 0.4	8	-8
LVCMOS 2.5	-0.3	0.7	1.7	3.6	0.4	VCCIO - 0.4	12	-12
							16	-16
					0.2	V <sub>CCIO</sub> - 0.2	0.1	-0.1
							4	-4
LVCMOS 1.8	-0.3	0.051/	0.651/	3.6	0.4	V <sub>CCIO</sub> - 0.4	8	-8
		0.35V <sub>CCIO</sub>	0.65V <sub>CCIO</sub>	3.0			12	-12
					0.2	V <sub>CCIO</sub> - 0.2	0.1	-0.1
		0.35V <sub>CCIO</sub>	0.65V <sub>CCIO</sub>		0.4	V 04	4	-4
LVCMOS 1.5	-0.3			3.6	0.4	V <sub>CCIO</sub> - 0.4	8	-8
					0.2	V <sub>CCIO</sub> - 0.2	0.1	-0.1
		0.35V <sub>CCIO</sub>	0.65V <sub>CCIO</sub>	3.6	0.4	V 0.4	4	-2
LVCMOS 1.2	-0.3				0.4	V <sub>CCIO</sub> - 0.4	8	-6
					0.2	V <sub>CCIO</sub> - 0.2	0.1	-0.1
LVCMOS25R33	-0.3	VREF-0.1	VREF+0.1	3.6	NA	NA	NA	NA
LVCMOS18R33	-0.3	VREF-0.1	VREF+0.1	3.6	NA	NA	NA	NA
LVCMOS18R25	-0.3	VREF-0.1	VREF+0.1	3.6	NA	NA	NA	NA
LVCMOS15R33	-0.3	VREF-0.1	VREF+0.1	3.6	NA	NA	NA	NA
LVCMOS15R25	-0.3	VREF-0.1	VREF+0.1	3.6	NA	NA	NA	NA
LVCMOS12R33	-0.3	VREF-0.1	VREF+0.1	3.6	0.40	NA Open Drain	24, 16, 12, 8, 4	NA Open Drain
LVCMOS12R25	-0.3	VREF-0.1	VREF+0.1	3.6	0.40	NA Open Drain	16, 12, 8, 4	NA Open Drain
LVCMOS10R33	-0.3	VREF-0.1	VREF+0.1	3.6	0.40	NA Open Drain	24, 16, 12, 8, 4	NA Open Drain
LVCMOS10R25	-0.3	VREF-0.1	VREF+0.1	3.6	0.40	NA Open Drain	16, 12, 8, 4	NA Open Drain

 MachXO3L/LF devices allow LVCMOS inputs to be placed in I/O banks where V<sub>CCIO</sub> is different from what is specified in the applicable JEDEC specification. This is referred to as a ratioed input buffer. In a majority of cases this operation follows or exceeds the applicable JEDEC specification. The cases where MachXO3L/LF devices do not meet the relevant JEDEC specification are documented in the table below.

2. MachXO3L/LF devices allow for LVCMOS referenced I/Os which follow applicable JEDEC specifications. For more details about mixed mode operation please refer to please refer to TN1280, MachXO3 sysIO Usage Guide.

3. The dual function I<sup>2</sup>C pins SCL and SDA are limited to a  $V_{IL}$  min of -0.25 V or to -0.3 V with a duration of <10 ns.

4. For electromigration, the average DC current sourced or sinked by I/O pads between two consecutive VCCIO or GND pad connections, or between the last VCCIO or GND in an I/O bank and the end of an I/O bank, as shown in the Logic Signal Connections table (also shown as I/O grouping) shall not exceed a maximum of n \* 8 mA. "n" is the number of I/O pads between the two consecutive bank VCCIO or GND connections or between the last VCCIO and GND in a bank and the end of a bank. IO Grouping can be found in the Data Sheet Pin Tables, which can also be generated from the Lattice Diamond software.



# MachXO3L/LF External Switching Characteristics – C/E Devices<sup>1, 2, 3, 4, 5, 6, 10</sup>

			_	6	-	5	
Parameter	Description	Device	Min.	Max.	Min.	Max.	Units
Clocks		I					
Primary Clo	ocks						
f <sub>MAX_PRI</sub> <sup>7</sup>	Frequency for Primary Clock Tree	All MachXO3L/LF devices		388	—	323	MHz
t <sub>W_PRI</sub>	Clock Pulse Width for Primary Clock	All MachXO3L/LF devices	0.5	_	0.6		ns
		MachXO3L/LF-1300	_	867	—	897	ps
		MachXO3L/LF-2100		867	_	897	ps
t <sub>SKEW_PRI</sub>	Primary Clock Skew Within a Device	MachXO3L/LF-4300		865	_	892	ps
0.12.1		MachXO3L/LF-6900		902	_	942	ps
		MachXO3L/LF-9400	_	908	_	950	ps
Edge Clock							
f <sub>MAX_EDGE</sub> <sup>7</sup>	Frequency for Edge Clock	MachXO3L/LF	_	400	_	333	MHz
_	n Propagation Delay						
t <sub>PD</sub>	Best case propagation delay through one LUT-4	All MachXO3L/LF devices	_	6.72	_	6.96	ns
General I/O	Pin Parameters (Using Primary Clock with	out PLL)		I			1
		MachXO3L/LF-1300	—	7.46	_	7.66	ns
		MachXO3L/LF-2100	_	7.46	—	7.66	ns
Clock to Clock	Clock to Output - PIO Output Register	MachXO3L/LF-4300	_	7.51	_	7.71	ns
00		MachXO3L/LF-6900	_	7.54	_	7.75	ns
		MachXO3L/LF-9400	_	7.53	_	7.83	ns
		MachXO3L/LF-1300	-0.20	—	-0.20	—	ns
		MachXO3L/LF-2100	-0.20		-0.20		ns
t <sub>SU</sub>	Clock to Data Setup - PIO Input Register	MachXO3L/LF-4300	-0.23		-0.23		ns
		MachXO3L/LF-6900	-0.23	_	-0.23		ns
		MachXO3L/LF-9400	-0.24	—	-0.24	—	ns
		MachXO3L/LF-1300	1.89		2.13		ns
		MachXO3L/LF-2100	1.89		2.13		ns
t <sub>H</sub>	Clock to Data Hold - PIO Input Register	MachXO3L/LF-4300	1.94	_	2.18	_	ns
		MachXO3L/LF-6900	1.98		2.23		ns
		MachXO3L/LF-9400	1.99		2.24		ns
		MachXO3L/LF-1300	1.61		1.76		ns
		MachXO3L/LF-2100	1.61		1.76		ns
t <sub>SU_DEL</sub>	Clock to Data Setup - PIO Input Register	MachXO3L/LF-4300	1.66	_	1.81	_	ns
00_DEE	with Data Input Delay	MachXO3L/LF-6900	1.53	_	1.67	_	ns
		MachXO3L/LF-9400	1.65	_	1.80	<u> </u>	ns
		MachXO3L/LF-1300	-0.23	_	-0.23	_	ns
		MachXO3L/LF-2100	-0.23	_	-0.23	_	ns
t <sub>H_DEL</sub>	Clock to Data Hold - PIO Input Register with	MachXO3L/LF-4300	-0.25		-0.25		ns
	Input Data Delay	MachXO3L/LF-6900	-0.21		-0.21		ns
		MachXO3L/LF-9400	-0.24		-0.24		ns
f <sub>MAX_IO</sub>	Clock Frequency of I/O and PFU Register	All MachXO3L/LF devices		388		323	MHz

## Over Recommended Operating Conditions



			_	-6	-5		
Parameter	Description	Device	Min.	Max.	Min.	Max.	Units
	RX1 Inputs with Clock and Data Aligned at	Pin Using PCLK Pin for Cl	ock Inpu	it —			
	X.SCLK.Aligned <sup>8,9</sup>	J	•				
t <sub>DVA</sub>	Input Data Valid After CLK		—	0.317		0.344	UI
t <sub>DVE</sub>	Input Data Hold After CLK	All MachXO3L/LF devices,	0.742	—	0.702		UI
f <sub>DATA</sub>	DDRX1 Input Data Speed	all sides	—	300	—	250	Mbps
f <sub>DDRX1</sub>	DDRX1 SCLK Frequency		—	150		125	MHz
Generic DD GDDRX1_R	RX1 Inputs with Clock and Data Centered X.SCLK.Centered <sup>8, 9</sup>	d at Pin Using PCLK Pin fo	or Clock	Input –			
t <sub>SU</sub>	Input Data Setup Before CLK		0.566	—	0.560	—	ns
t <sub>HO</sub>	Input Data Hold After CLK	All MachXO3L/LF devices,	0.778	—	0.879		ns
f <sub>DATA</sub>	DDRX1 Input Data Speed	all sides	—	300	—		Mbps
f <sub>DDRX1</sub>	DDRX1 SCLK Frequency		—	150	—	125	MHz
	RX2 Inputs with Clock and Data Aligned a X.ECLK.Aligned <sup>8, 9</sup>	t Pin Using PCLK Pin for (	Clock Inp	out –			
t <sub>DVA</sub>	Input Data Valid After CLK			0.316		0.342	UI
t <sub>DVE</sub>	Input Data Hold After CLK	-	0.710	_	0.675		UI
f <sub>DATA</sub>	DDRX2 Serial Input Data Speed	MachXO3L/LF devices,		664		554	Mbps
f <sub>DDRX2</sub>	DDRX2 ECLK Frequency			332		277	MHz
f <sub>SCLK</sub>	SCLK Frequency	-		166		139	MHz
Generic DD	RX2 Inputs with Clock and Data Centered X.ECLK.Centered <sup>8,9</sup>	at Pin Using PCLK Pin for	Clock I	nput –			
t <sub>SU</sub>	Input Data Setup Before CLK	MachXO3L/LF devices, bottom side only	0.233		0.219		ns
t <sub>HO</sub>	Input Data Hold After CLK		0.287		0.287		ns
f <sub>DATA</sub>	DDRX2 Serial Input Data Speed		_	664		554	Mbps
f <sub>DDRX2</sub>	DDRX2 ECLK Frequency		_	332		277	MHz
f <sub>SCLK</sub>	SCLK Frequency		_	166		139	MHz
-	R4 Inputs with Clock and Data Aligned at F	In Using PCLK Pin for Clo	ck Input	– GDDR	X4_RX.	ECLK.A	ligned <sup>8</sup>
t <sub>DVA</sub>	Input Data Valid After ECLK		· -	0.307		0.320	UI
t <sub>DVE</sub>	Input Data Hold After ECLK		0.782		0.699		UI
f <sub>DATA</sub>	DDRX4 Serial Input Data Speed	MachXO3L/LF devices, bottom side only at Pin Using PCLK Pin for Clock MachXO3L/LF devices, bottom side only	_	800		630	Mbps
f <sub>DDRX4</sub>	DDRX4 ECLK Frequency		_	400		315	MHz
f <sub>SCLK</sub>	SCLK Frequency	-	_	100		79	MHz
	R4 Inputs with Clock and Data Centered at I	Pin Using PCLK Pin for Cloc	k Input -	- GDDR	X4_RX.E	ECLK.Ce	entered <sup>8</sup>
t <sub>SU</sub>	Input Data Setup Before ECLK		0.233	—	0.219	—	ns
t <sub>HO</sub>	Input Data Hold After ECLK	-	0.287	_	0.287		ns
f <sub>DATA</sub>	DDRX4 Serial Input Data Speed		_	800		630	Mbps
f <sub>DDRX4</sub>	DDRX4 ECLK Frequency		_	400		315	MHz
f <sub>SCLK</sub>	SCLK Frequency	-	_	100		79	MHz
	puts (GDDR71_RX.ECLK.7:1) <sup>9</sup>						ł
t <sub>DVA</sub>	Input Data Valid After ECLK			0.290	_	0.320	UI
t <sub>DVE</sub>	Input Data Hold After ECLK	1	0.739		0.699		UI
f <sub>DATA</sub>	DDR71 Serial Input Data Speed	MachXO3L/LF devices,		756	_	630	Mbps
f <sub>DDR71</sub>	DDR71 ECLK Frequency	bottom side only		378	_	315	MHz
fCLKIN	7:1 Input Clock Frequency (SCLK) (mini- mum limited by PLL)		_	108	_	90	MHz



# I<sup>2</sup>C Port Timing Specifications<sup>1, 2</sup>

Symbol	Parameter	Min.	Max.	Units
f <sub>MAX</sub>	Maximum SCL clock frequency	_	400	kHz

1. MachXO3L/LF supports the following modes:

• Standard-mode (Sm), with a bit rate up to 100 kbit/s (user and configuration mode)

• Fast-mode (Fm), with a bit rate up to 400 kbit/s (user and configuration mode)

2. Refer to the  $I^2C$  specification for timing requirements.

# SPI Port Timing Specifications<sup>1</sup>

Symbol	Parameter	Min.	Max.	Units
f <sub>MAX</sub>	Maximum SCK clock frequency	—	45	MHz

1. Applies to user mode only. For configuration mode timing specifications, refer to sysCONFIG Port Timing Specifications table in this data sheet.

# **Switching Test Conditions**

Figure 3-9 shows the output test load used for AC testing. The specific values for resistance, capacitance, voltage, and other test conditions are shown in Table 3-6.

#### Figure 3-9. Output Test Load, LVTTL and LVCMOS Standards



Table 3-6. Test Fixture Required Components,	Non-Terminated Interfaces
--	---------------------------

Test Condition	R1	CL	Timing Ref.	VT				
			LVTTL, LVCMOS 3.3 = 1.5 V	—				
			LVCMOS 2.5 = $V_{CCIO}/2$	_				
LVTTL and LVCMOS settings (L -> H, H -> L)	$\infty$	0pF	LVCMOS 1.8 = $V_{CCIO}/2$	_				
			LVCMOS 1.5 = $V_{CCIO}/2$					
			LVCMOS 1.2 = $V_{CCIO}/2$					
LVTTL and LVCMOS 3.3 (Z -> H)			1.5	V <sub>OL</sub>				
LVTTL and LVCMOS 3.3 (Z -> L)			1.5	V <sub>OH</sub>				
Other LVCMOS (Z -> H) Other LVCMOS (Z -> L)	188	0pF	V <sub>CCIO</sub> /2	V <sub>OL</sub>				
	100	opr	V <sub>CCIO</sub> /2	V <sub>OH</sub>				
LVTTL + LVCMOS (H -> Z)	1		V <sub>OH</sub> - 0.15	V <sub>OL</sub>				
LVTTL + LVCMOS (L -> Z)			V <sub>OL</sub> - 0.15	V <sub>OH</sub>				

Note: Output test conditions for all other interfaces are determined by the respective standards.



# Signal Descriptions (Cont.)

Signal Name	I/O	Descriptions					
Configuration (Dual function pins used during sysCONFIG)							
PROGRAMN	I	Initiates configuration sequence when asserted low. This pin always has an active pull-up.					
INITN	I/O	Open Drain pin. Indicates the FPGA is ready to be configured. During configuration, a pull-up is enabled.					
DONE	I/O	Open Drain pin. Indicates that the configuration sequence is complete, and the start-up sequence is in progress.					
MCLK/CCLK	I/O	Input Configuration Clock for configuring an FPGA in Slave SPI mode. Output Configuration Clock for configuring an FPGA in SPI and SPIm configuration modes.					
SN	I	Slave SPI active low chip select input.					
CSSPIN	I/O	Master SPI active low chip select output.					
SI/SPISI	I/O	Slave SPI serial data input and master SPI serial data output.					
SO/SPISO	I/O	Slave SPI serial data output and master SPI serial data input.					
SCL	I/O	Slave I <sup>2</sup> C clock input and master I <sup>2</sup> C clock output.					
SDA	I/O	Slave I <sup>2</sup> C data input and master I <sup>2</sup> C data output.					



	MachXO3L/LF-2100					
	WLCSP49	CSFBGA121	CSFBGA256	CSFBGA324	CABGA256	CABGA324
General Purpose IO per Bank	1					
Bank 0	19	24	50	71	50	71
Bank 1	0	26	52	62	52	68
Bank 2	13	26	52	72	52	72
Bank 3	0	7	16	22	16	24
Bank 4	0	7	16	14	16	16
Bank 5	6	10	20	27	20	28
Total General Purpose Single Ended IO	38	100	206	268	206	279
Differential IO per Bank	1					
Bank 0	10	12	25	36	25	36
Bank 1	0	13	26	30	26	34
Bank 2	6	13	26	36	26	36
Bank 3	0	3	8	10	8	12
Bank 4	0	3	8	6	8	8
Bank 5	3	5	10	13	10	14
Total General Purpose Differential IO	19	49	103	131	103	140
Dual Function IO	25	33	33	37	33	37
Number 7:1 or 8:1 Gearboxes	•			•	•	•
Number of 7:1 or 8:1 Output Gearbox Available (Bank 0)	5	7	14	18	14	18
Number of 7:1 or 8:1 Input Gearbox Available (Bank 2)	6	13	14	18	14	18
High-speed Differential Outputs	•			•	•	•
Bank 0	5	7	14	18	14	18
VCCIO Pins	1					
Bank 0	2	1	4	4	4	4
Bank 1	0	1	3	4	4	4
Bank 2	1	1	4	4	4	4
Bank 3	0	1	2	2	1	2
Bank 4	0	1	2	2	2	2
Bank 5	1	1	2	2	1	2
VCC	2	4	8	8	8	10
GND	4	10	24	16	24	16
NC	0	0	0	13	1	0
Reserved for Configuration	1	1	1	1	1	1
Total Count of Bonded Pins	49	121	256	324	256	324



LCMXO3L-9400C-6BG4841

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IND

Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3L-6900E-5MG256C	6900	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3L-6900E-6MG256C	6900	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3L-6900E-5MG256I	6900	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3L-6900E-6MG256I	6900	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3L-6900E-5MG324C	6900	1.2 V	5	Halogen-Free csfBGA	324	COM
LCMXO3L-6900E-6MG324C	6900	1.2 V	6	Halogen-Free csfBGA	324	COM
LCMXO3L-6900E-5MG324I	6900	1.2 V	5	Halogen-Free csfBGA	324	IND
LCMXO3L-6900E-6MG324I	6900	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3L-6900C-5BG256C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3L-6900C-6BG256C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3L-6900C-5BG256I	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3L-6900C-6BG256I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3L-6900C-5BG324C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3L-6900C-6BG324C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3L-6900C-5BG324I	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3L-6900C-6BG324I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND
LCMXO3L-6900C-5BG400C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	COM
LCMXO3L-6900C-6BG400C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3L-6900C-5BG4001	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3L-6900C-6BG400I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	IND
			<u> </u>	<b></b>		-
Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3L-9400E-5MG256C	9400	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3L-9400E-6MG256C	9400	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3L-9400E-5MG256I	9400	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3L-9400E-6MG256I	9400	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3L-9400C-5BG256C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3L-9400C-6BG256C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3L-9400C-5BG256I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3L-9400C-6BG256I	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3L-9400C-5BG400C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	400	COM
LCMXO3L-9400C-6BG400C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3L-9400C-5BG400I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3L-9400C-6BG400I	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	400	IND
LCMXO3L-9400C-5BG484C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	484	COM
LCMXO3L-9400C-6BG484C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	484	COM
LCMXO3L-9400C-5BG484I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	484	IND

2.5 V/3.3 V

6

Halogen-Free caBGA

9400



Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-2100E-6MG324I	2100	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3LF-2100C-5BG256C	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-2100C-6BG256C	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-2100C-5BG256I	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-2100C-6BG256I	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-2100C-5BG324C	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3LF-2100C-6BG324C	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3LF-2100C-5BG324I	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3LF-2100C-6BG324I	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND
Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-4300E-5UWG81CTR	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81CTR50	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81CTR1K	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81ITR	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5UWG81ITR50	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5UWG81ITR1K	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5MG121C	4300	1.2 V	5	Halogen-Free csfBGA	121	COM
LCMXO3LF-4300E-6MG121C	4300	1.2 V	6	Halogen-Free csfBGA	121	COM
LCMXO3LF-4300E-5MG121I	4300	1.2 V	5	Halogen-Free csfBGA	121	IND
LCMXO3LF-4300E-6MG121I	4300	1.2 V	6	Halogen-Free csfBGA	121	IND
LCMXO3LF-4300E-5MG256C	4300	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3LF-4300E-6MG256C	4300	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3LF-4300E-5MG256I	4300	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3LF-4300E-6MG256I	4300	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3LF-4300E-5MG324C	4300	1.2 V	5	Halogen-Free csfBGA	324	COM
LCMXO3LF-4300E-6MG324C	4300	1.2 V	6	Halogen-Free csfBGA	324	COM
LCMXO3LF-4300E-5MG324I	4300	1.2 V	5	Halogen-Free csfBGA	324	IND
LCMXO3LF-4300E-6MG324I	4300	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3LF-4300C-5BG256C	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-4300C-6BG256C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-4300C-5BG256I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-4300C-6BG256I	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-4300C-5BG324C	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3LF-4300C-6BG324C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3LF-4300C-5BG324I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3LF-4300C-6BG324I	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND
LCMXO3LF-4300C-5BG400C	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	COM
LCMXO3LF-4300C-6BG400C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3LF-4300C-5BG400I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3LF-4300C-6BG400I	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	IND



Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-6900E-5MG256C	6900	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3LF-6900E-6MG256C	6900	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3LF-6900E-5MG256I	6900	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3LF-6900E-6MG256I	6900	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3LF-6900E-5MG324C	6900	1.2 V	5	Halogen-Free csfBGA	324	COM
LCMXO3LF-6900E-6MG324C	6900	1.2 V	6	Halogen-Free csfBGA	324	COM
LCMXO3LF-6900E-5MG324I	6900	1.2 V	5	Halogen-Free csfBGA	324	IND
LCMXO3LF-6900E-6MG324I	6900	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3LF-6900C-5BG256C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-6900C-6BG256C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-6900C-5BG256I	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-6900C-6BG256I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-6900C-5BG324C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3LF-6900C-6BG324C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3LF-6900C-5BG324I	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3LF-6900C-6BG324I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND
LCMXO3LF-6900C-5BG400C	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	COM
LCMXO3LF-6900C-6BG400C	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3LF-6900C-5BG400I	6900	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3LF-6900C-6BG400I	6900	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	IND
Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-9400E-5MG256C	9400	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3LF-9400E-6MG256C	9400	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3LF-9400E-5MG256I	9400	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3LF-9400E-6MG256I	9400	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3LF-9400C-5BG256C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-9400C-6BG256C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-9400C-5BG256I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-9400C-6BG256I	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-9400C-5BG400C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	400	COM
LCMXO3LF-9400C-6BG400C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3LF-9400C-5BG400I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3LF-9400C-6BG400I	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	400	IND
LCMXO3LF-9400C-5BG484C	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	484	COM
LCMXO3LF-9400C-6BG484C	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	484	COM
LCMXO3LF-9400C-5BG484I	9400	2.5 V/3.3 V	5	Halogen-Free caBGA	484	IND
LCMXO3LF-9400C-6BG484I	9400	2.5 V/3.3 V	6	Halogen-Free caBGA	484	IND